

Docket No.: 5417-0132PUS1
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Fumio KUROTORI et al.

Application No.: 10/566,463

Confirmation No.: 3853

Filed: January 30, 2006

Art Unit: 2829

For: CONTACT PIN, PROBE CARD AND
ELECTRONIC DEVICE TEST APPARATUS
USING SAME

Examiner: T. X. Nguyen

**AMENDMENT WITH THE FILING OF A REQUEST FOR CONTINUED
EXAMINATION**

MS RCE
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INTRODUCTORY COMMENTS

In response to the Office Action dated June 11, 2009, please amend the above-identified U.S. patent application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks/Arguments begin on page 7 of this paper.